MOS FET

Unit: mm

0. 16

FK8V03050L

### **Panasonic**

#### FK8V03050L

#### Silicon N-channel MOSFET

For lithium-ion secondary battery protection circuit For DC-DC Converter

#### ■ Features

- Low drain-source On-state Resistance RDS(on) typ = 16 m $\Omega$  (VGS = 4.5 V)
- High-speed switching : Qg = 5.1 nC
- Halogen-free / RoHS compliant (EU RoHS / UL-94 V-0 / MSL:Level 1 compliant)
- Marking Symbol: 3E

#### ■ Packaging

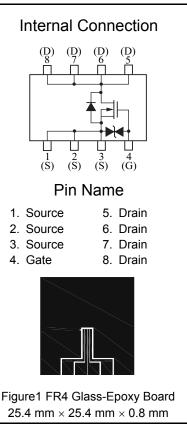
Embossed type (Thermo-compression sealing): 3 000 pcs / reel (standard)

4 8 (0.81)0.65 5. Drain 1. Source 2. Source 6. Drain 3. Source 7. Drain 8. Drain 4. Gate WMini8-F1 Panasonic JEITA SC-115 Code

Parameter	Symbol	Rating	Unit
Drain-source Voltage	VDS	33	V
Gate-source Voltage	VGS	±20	V
Drain Current (Steady State) *1	ID	8	
Drain Current (t = 10 s) *1	טו	10	
Drain Current (Pulsed) *1,*2	IDp	32	Α
Source Current (Pulsed)	ISp	8	
(Body Diode) *1,*2	(BD)	0	
Total Power Dissipation (Steady State) *1	PD	1	W
Total Power Dissipation (t = 10 s) *1	וט	1.5	VV
Channel Temperature	Tch	150	°C
Operating Ambient Temperature	Topr	-40 to +85	°C
Storage Temperature Range	Tstg	-55 to +150	°C

Note) \*1 Device mounted on a glass-epoxy board (See Figure 1)

\*2 Pulse test: Ensure that the channel temperature does not exceed 150°C



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#### ■ Electrical Characteristics Ta = 25°C ± 3°C

#### Static Characteristics

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Drain-source Breakdown Voltage	VDSS	ID = 1 mA, VGS = 0 V	33			V
Zero Gate Voltage Drain Current	IDSS	VDS = 33 V, VGS = 0 V			10	μΑ
Gate-source Leakage Current	IGSS	VGS = ±16 V, VDS = 0 V			±10	μΑ
Gate-source Threshold Voltage	Vth	ID = 0.73 mA, VDS = 10 V	1		2.5	V
Drain-cource On-state Pecietance	RDS(on)1	ID = 4A, VGS = 10 V		11	15	mΩ
	RDS(on)2	ID = 4A, VGS = 4.5 V		16	25	

#### **Dynamic Characteristics**

Input Capacitance	Ciss	VDS = 10 V, VGS = 0 V,	520	
Output Capacitance	Coss	f = 1 MHz	110	pF
Reverse Transfer Capacitance	Crss	1 - 1 1011 12	70	
Turn-on Delay Time *2	td(on)	VDD = 15 V, VGS = 0 to 10 V	8	
Rise Time *2	tr	ID = 4 A	4	ns
Turn-off Delay Time *2	td(off)	VDD = 15 V, VGS = 10 to 0 V	32	115
Fall Time *2	tf	ID = 4 A	10	
Total Gate Charge	Qg	VDD = 15 V, VGS = 0 to 4.5 V,	5.1	
Gate-source Charge	Qgs	ID = 8 A	1.8	nC
Gate-drain Charge	Qgd	ID - 0 A	2.3	

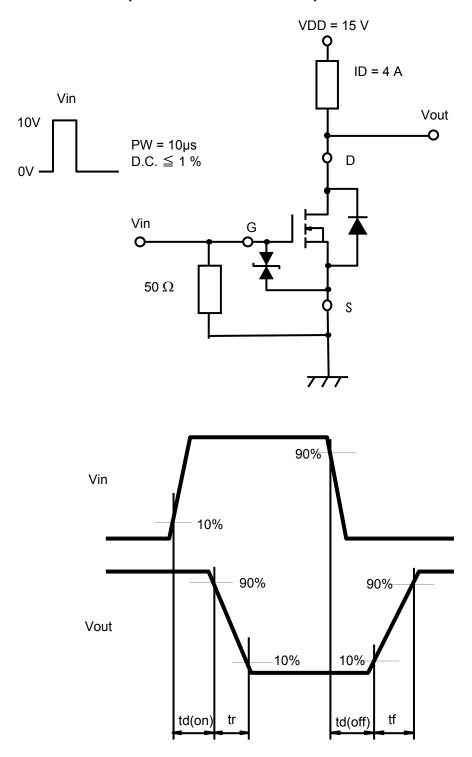
Body Diode Characteristic					
Diode Forward Voltage *1	VSD	IS = 4 A, VGS = 0 V	0.8	1.2	V

Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 Measuring methods for transistors.

<sup>2. \*1</sup> Pulse test: Ensure that the channel temperature does not exceed 150°C

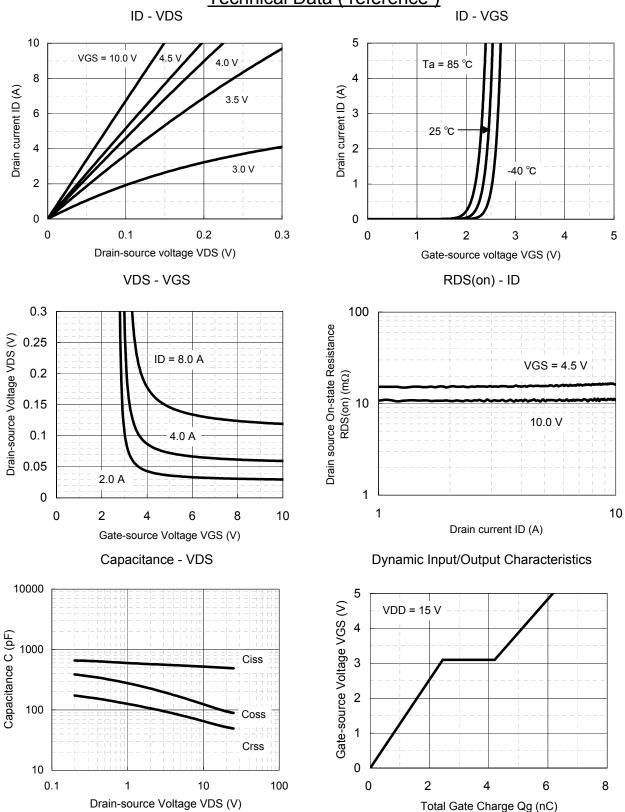
<sup>\*2</sup> Measurement circuit for Turn-on Delay Time/Rise Time/Turn-off Delay Time/Fall Time

\*2 Measurement circuit for Turn-on Delay Time/Rise Time/Turn-off Delay Time/Fall Time



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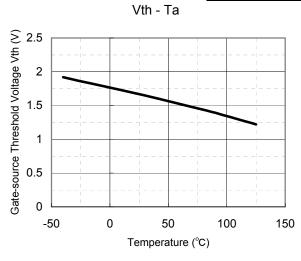
### Technical Data ( reference )

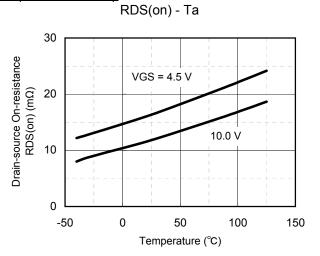


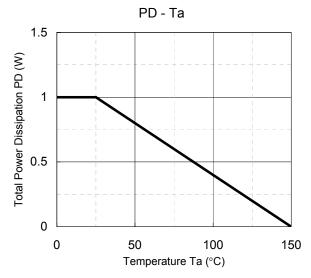
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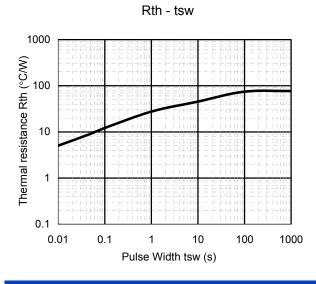
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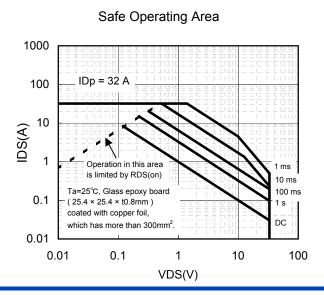
### Technical Data (reference)









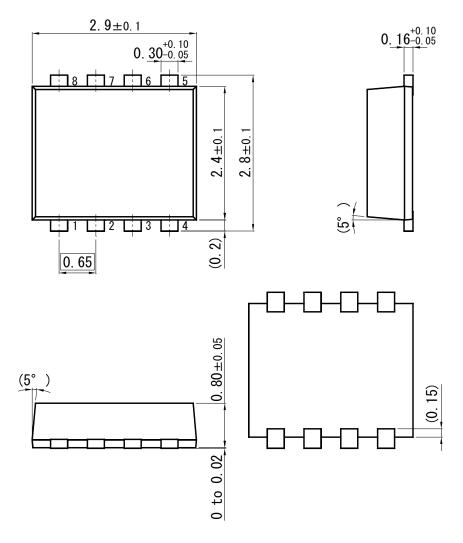


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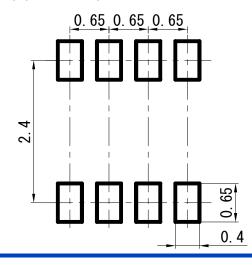
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WMini8-F1

Unit: mm



■ Land Pattern (Reference) (Unit: mm)



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